

Notice of References Cited	Application/Control No. 09/550,078	Applicant(s)/Patent Under Reexamination YOSHIO ET AL.	
	Examiner Devona E. Faulk	Art Unit 2615	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,618,396	09-2003	Kondo et al.	370/474
*	B	US-6,144,411	11-2000	Kobayashi et al.	348/441
*	C	US-5,802,017	09-1998	Sato et al.	369/2
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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